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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: T. NAKATA, et al

Serial No.: 09/437,265

Filed: November 10, 1999

For: METHOD FOR MEASURING DIMENSIONS AND ALIGNMENT OF

THIN FILM MAGNETIC HEAD AND APPARATUS THEREFOR

Group: 2877

## STATEMENT OF THE SUBSTANCE OF THE INTERVIEW

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450 June 2, 2004

Sir:

Based on review of the Examiner's Interview Summary (Paper No. 0504) dated May 26, 2004, Applicant agrees that the statement provided therein is true and accurate.

Respectfully submitted,

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